

PTA07N65B

(PK) Lead Free Package and Finish

R_{DS(ON),Typ.}

1.2Ω

650V N-ch Planar MOSFET

General Features

- RoHS Compliant
- $R_{DS(ON),typ.} = 1.2 \ \Omega @V_{GS} = 10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

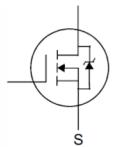
- Adaptor
- Charger
- SMPS Standby Power

Ordering Information

Part Number	Package	Brand
PTA07N65B	TO-220F	ï

Absolute Maximum Ratings

GDS	G	(
TO-220F		



 I_{D}

7.0A

D

Package Not to Scale

BV_{DSS}

650V

 $T_C{=}25\,^\circ\!\mathrm{C}$ unless otherwise specified

Symbol	Parameter	PTA07N65B	Unit	
V _{DSS}	Drain-to-Source Voltage	650	V	
V _{GSS}	V _{GSS} Gate-to-Source Voltage		V	
I _D	I _D Continuous Drain Current			
I _{DM}	Pulsed Drain Current at V _{GS} =10V	28	A	
E _{AS}	Single Pulse Avalanche Energy	550	mJ	
П	Power Dissipation	42	W	
P _D	Derating Factor above 25° C	0.34	W/°C	
TL TPAKMaximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds		300 260	°C	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTA07N65B	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	2.98	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	100	°C W



Electrical Characteristics

OFF Characteristics

1

OFF Characteristics					T_J =25 $^\circ\!\!\!\mathrm{C}$ unless otherwise specified		
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
BV _{DSS}	Drain-to-Source Breakdown Voltage	650			V	V_{GS} =0V, I _D =250uA	
				1		V_{DS} =650V, V_{GS} =0V	
IDSS	Drain-to-Source Leakage Current	100 uA	UA	V _{DS} =520V, V _{GS} =0V, T _J =125℃			
	Gate-to-Source Leakage Current			+100	nA	V_{GS} =+30V, V_{DS} =0V	
I _{GSS}	Gale-10-Source Leakage Current			-100		V_{GS} =-30V, V_{DS} =0V	

ON Characteristics				T_J =25°C unless otherwise specified		
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		1.2	1.40	Ω	V_{GS} =10V, I _D =3.0A
$V_{GS(TH)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_{D}=250uA$
gfs	Forward Transconductance		11		S	VDS=30V,ID=3.5A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		1120		pF	V_{GS} =0V, V_{DS} =25V, f=1.0MH _Z
C _{rss}	Reverse Transfer Capacitance		10			
C _{oss}	Output Capacitance		90			
Qg	Total Gate Charge		20			
Q _{gs}	Gate-to-Source Charge		5		nC	V_{DD} =325V, I _D =7A, V_{GS} =0 to 10V
Q _{gd}	Gate-to-Drain (Miller) Charge		5			

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		12		ns	V_{DD} =325V, I_{D} =7A, V_{GS} =10V Rg=4.7 Ω
trise	Rise Time		12			
td(OFF)	Turn-Off Delay Time		18			
tfall	Fall Time		10			



Source-Drain Body Diode Characteristics

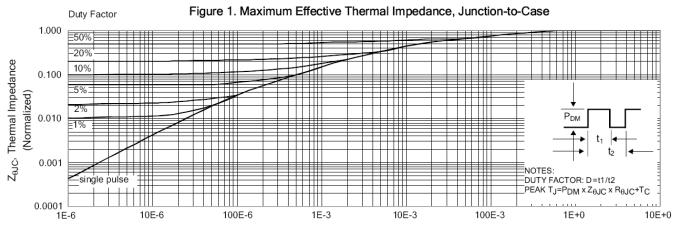
 $T_J\!=\!25^\circ\!\!\mathbb{C}$ unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]			7.0	A	Integral pn-diode in MOSFET
I _{SM}	Pulsed Source Current ^[2]			28		
V_{SD}	Diode Forward Voltage			1.5	V	I _S =7A, V _{GS} =0V
trr	Reverse Recovery Time		350		ns	Vgs=0V
Qrr	Reverse Recovery Charge		1.1		uC	l⊧=7A, di/dt=100A/µs

Note:

[1] T_J=+25℃ to +150℃ [2] Pulse width≤380µs; duty cycle≤2%.

Typical Characteristics



t_p, Rectangular Pulse Duration (s)

Figure 2. Maximum Power Dissipation vs Case Temperature

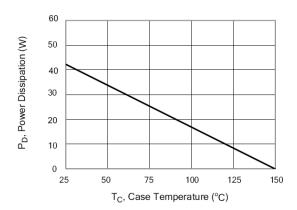


Figure 4. Typical Output Characteristics

20 PULSE DURATION = 250 µS DUTY FACTOR = 0.5% GS = 15V MAX, T_C = 25°C VGS = 7.0V I_D, Drain Current (A) 15 GS = 6.5V 10 GS = 6.0V 5 VGS = 5.5V VGS = 5.0V0 0 20 25 5 10 30 15 V_{DS}, Drain-to-Source Voltage (V)

Figure 3. Maximum Continuous Drain Current vs Case Temperature

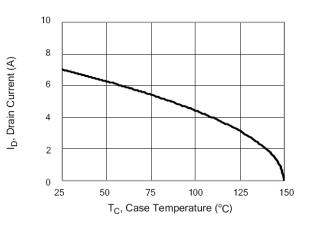
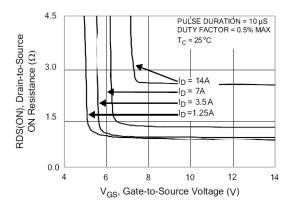
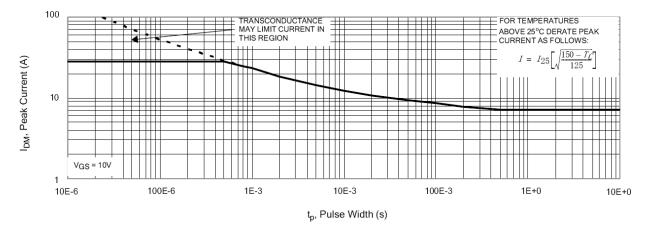


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current



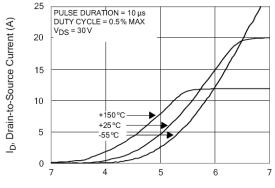
Typical Characteristics(Cont.)



I_{AS}, Avalanche Current (A)

Figure 6. Maximum Peak Current Capability

Figure 7. Typical Transfer Characteristics



 V_{GS} , Gate-to-Source Voltage (V)

Figure 9. Typical Drain-to-Source ON

7.50

0.00

0

5

10

15

I_D, Drain Current (A)

20

 $R_{DS(ON)}$, Drain-to-Source ON Resistance (Ω)

Resistance vs Drain Current

Figure 8. Unclamped Inductive Switching Capability

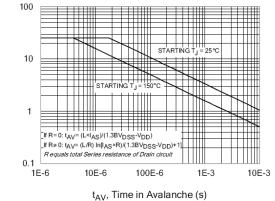
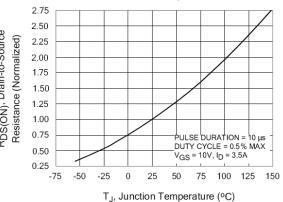
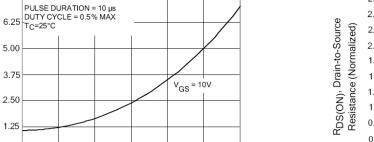


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature





25

30



1.E+02

1.E+01

1.E+00

1.E-01

1.E-02 + 1.0E-01

10

8

6

2

0

Vgs, gate to source voltage (v)

1.0E+00

ld, Drain Current, Amps

Typical Characteristics(Cont.)

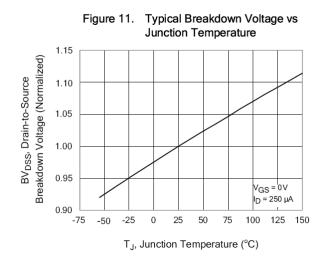


Figure 13 . Maximum Safe Operating Area

1.0E+01

Vds, Drain Source Voltage, Volts

Figure 15 . Typical Gate Charge

VDD=325V,ID=7A

1.0E+02

1.0E+03

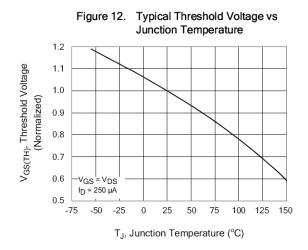


Figure 14. Capacitance vs Vds

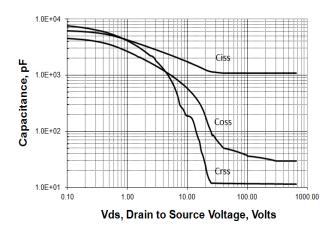
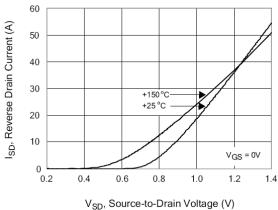


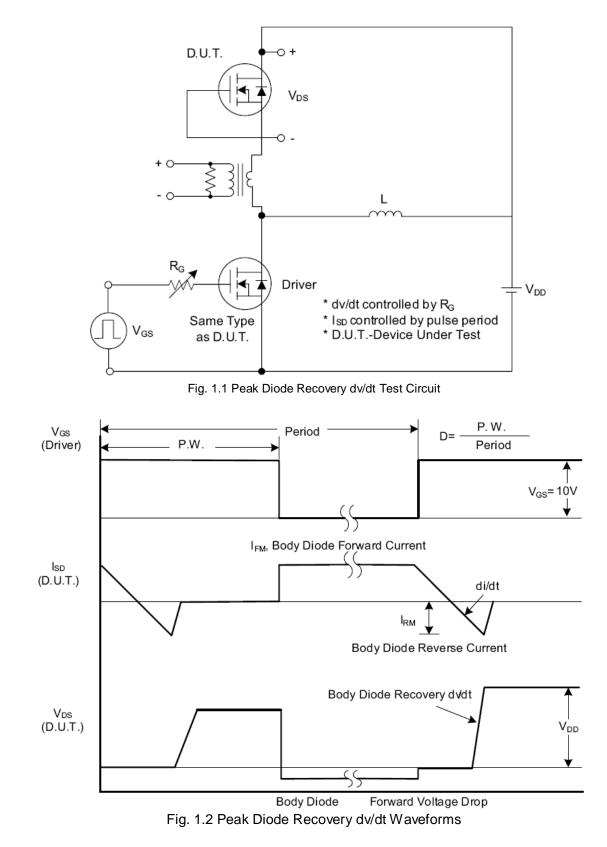
Figure 16. Typical Body Diode Transfer Characteristics







Test Circuits and Waveforms



Test Circuits and Waveforms (Cont.)

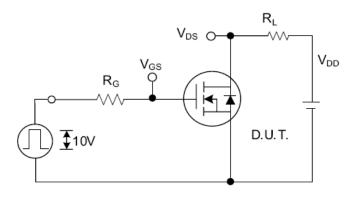


Fig. 2.1 Switching Test Circuit

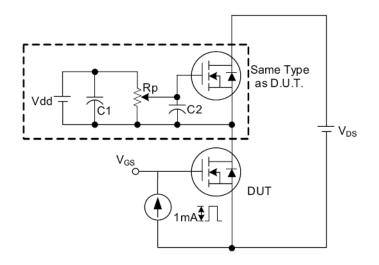


Fig. 3 . 1 Gate Charge Test Circuit

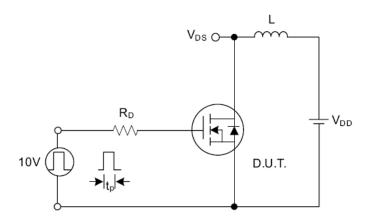


Fig. 4.1 Unclamped Inductive Switching Test Circuit

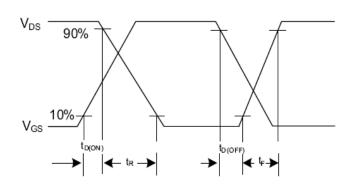
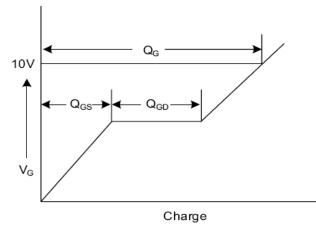
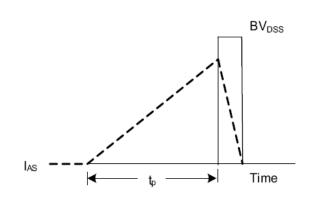


Fig. 2.2 Switching Waveforms











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